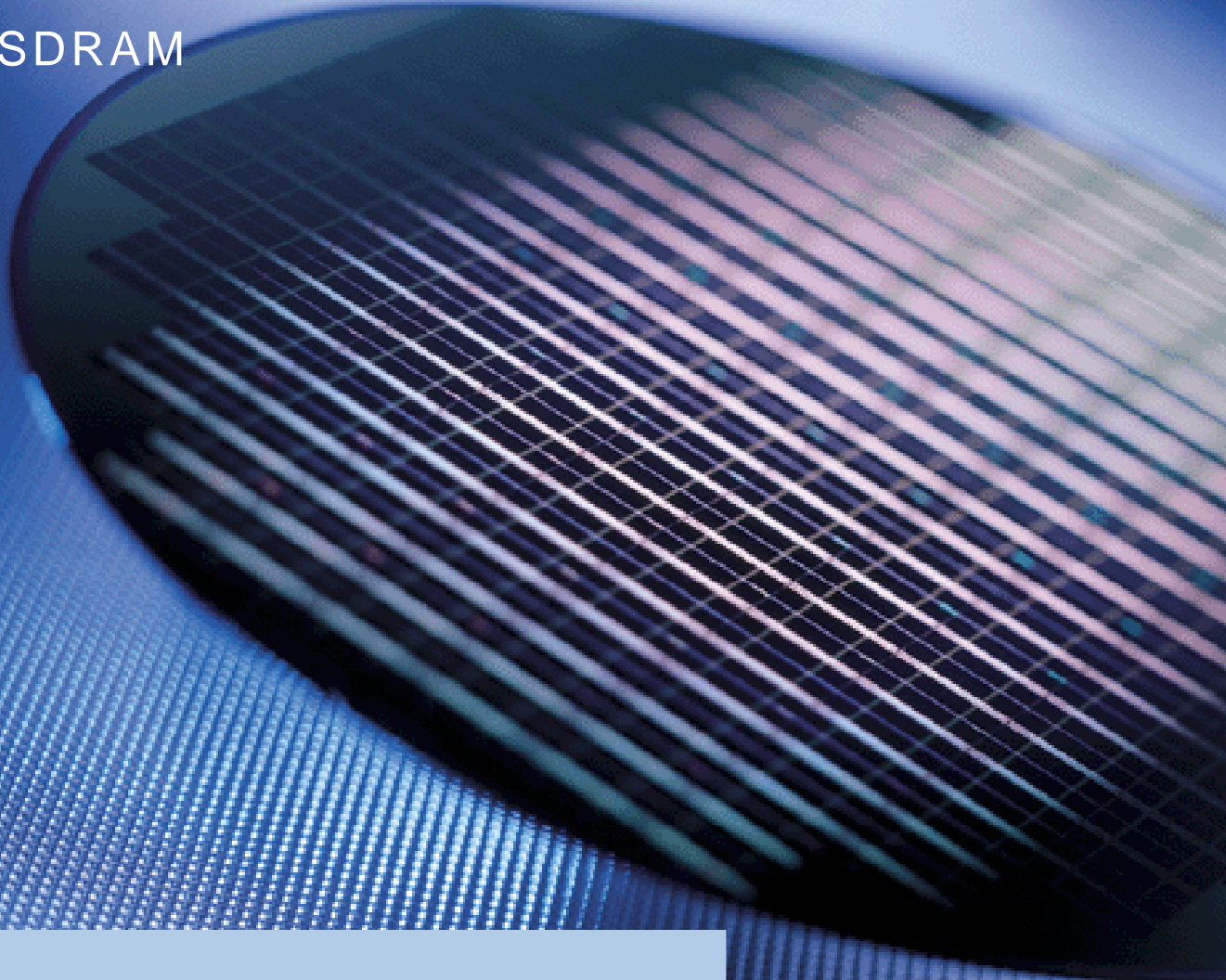


HYS64D[32020/16000]HDL-6-C

200-Pin Small Outline Dual-In-Line Memory Modules
SO-DIMM
DDR SDRAM



Memory Products



Never stop thinking.

Edition 2003-08

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N e v e r s t o p t h i n k i n g .

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200-Pin Small Outline Dual-In-Line Memory Modules HYS64D[32020/16000]HDL-6-C SO-DIMM

1 Overview

1.1 Features

- Non-parity 200-Pin Small Outline Dual-In-Line Memory Modules
- One rank 16M × 64 and two ranks 32M × 64 organization
- JEDEC standard Double Data Rate Synchronous DRAMs (DDR SDRAM)
- Single +2.5 V (± 0.2 V) power supply
- Built with 256 Mbit DDR SDRAMs organised as ×16 in P-TSOPII-66-1 packages
- Programmable CAS Latency, Burst Length, and Wrap Sequence (Sequential & Interleave)
- Auto Refresh (CBR) and Self Refresh
- All inputs and outputs SSTL_2 compatible
- Serial Presence Detect with E²PROM
- Jedec standard form factor: 67.60 mm × 31.75 mm × 2.4 / 3.80 mm
- Jedec standard reference layout Raw Cards A and C
- Gold plated contacts

Part Number Speed Code		-6	Unit
Speed Grade	Component	DDR333B	—
	Module	PC2700-2533	—
max. Clock Frequency	@CL3	f_{CK3}	166
	@CL2.5	$f_{CK2.5}$	166
	@CL2	f_{CK2}	133

1.2 Description

The HYS64D[32020/16000]HDL-6-C and are industry standard 200-Pin Small Outline Dual-In-Line Memory Modules (SO-DIMMs) organized as 32M × 64 and 16M × 64. The memory array is designed with Double Data Rate Synchronous DRAMs (DDR SDRAM). A variety of decoupling capacitors are mounted on the PC board. The DIMMs feature serial presence detect based on a serial E²PROM device using the 2-pin I²C protocol. The first 128 bytes are programmed with configuration data and the second 128 bytes are available to the customer.

Table 1 Ordering Information

Type	Compliance Code	Description	SDRAM Technology
PC2700 (CL=2.5)			
HYS64D16000HDL-6-C	PC2700S-2533-0-C1	one rank 128 MB SO-DIMM	256 MBit (×16)
HYS64D32020HDL-6-C	PC2700S-2533-0-A1	two ranks 256 MB SO-DIMM	256 MBit (×16)

Notes

1. All part numbers end with a place code designating the silicon-die revision. Reference information available on request. Example: HYS64D32020GDL-6-B, indicating rev. B dies are used for SDRAM components.
2. The Compliance Code is printed on the module labels describing the speed sort (for example "PC2700"), the latencies and SPD code definition (for example "2033-0" means CAS latency of 2.0 clocks, RCD¹⁾ latency of 3 clocks, Row Precharge latency of 3 clocks, and JEDEC SPD code definition version 0), and the Row Card used for this module.

1) RCD: Row-Column-Delay

2 Pin Configuration

Table 2 Pin Definitions and Functions

Symbol	Type ¹⁾	Function
A0 - A12	I	Address Inputs
BA0, BA1	I	Bank Address
DQ0 - DQ63	I/O	Data Input/Output
$\overline{\text{RAS}}$, $\overline{\text{CAS}}$, $\overline{\text{WE}}$	I	Command Input
CKE0 - CKE1	I	Clock Enable
DQS0 - DQS7	I/O	SDRAM Data Strobe
CK0 - CK1,	I	SDRAM Clock (true signal)
$\overline{\text{CK0}}$ - $\overline{\text{CK1}}$	I	SDRAM Clock (complementary signal)
DM0 - DM8	I	Data Mask
$\overline{\text{S0}}$, $\overline{\text{S1}}$ ²⁾	I	Chip Select
V_{DD}	PWR	Power (+ 2.5 V)
V_{SS}	GND	Ground
V_{DDQ}	PWR	I/O Driver power supply
V_{DDID}	PWR	VDD Identification flag
V_{REF}	AI	I/O reference supply
V_{DDSPD}	PWR	Serial EEPROM power supply
SCL	I	Serial bus clock
SDA	I/O	Serial bus data line
SA0 - SA2	I	slave address select
NC	NC	Not Connected
NU	NU	Not Usable, reserved for future use

1) I: Input; O: Output; I/O: bidirectional In-/Output; AI: Analog Input; PWR: Power Supply; GND: Signal Ground; NC: Not Connected; NU: Not Usable

2) CKE1 and $\overline{\text{S1}}$ are used on two bank modules only

Pin Configuration

Table 3 Pin Configuration

Front side		Back side		Front side		Back side		Front side		Back side	
Pin #	Symbol	Pin #	Symbol	Pin #	Symbol	Pin #	Symbol	Pin #	Symbol	Pin #	Symbol
1	V _{REF}	2	V _{REF}	65	DQ26	66	DQ30	133	DQS4	134	DM4
3	V _{SS}	4	V _{SS}	67	DQ27	68	DQ31	135	DQ34	136	DQ38
5	DQ0	6	DQ4	69	V _{DD}	70	V _{DD}	137	V _{SS}	138	V _{SS}
7	DQ1	8	DQ5	71	(CB0)	72	(CB4)	139	DQ35	140	DQ39
9	V _{DD}	10	V _{DD}	73	(CB1)	74	(CB5)	141	DQ40	142	DQ44
11	DQS0	12	DM0	75	V _{SS}	76	V _{SS}	143	V _{DD}	144	V _{DD}
13	DQ2	14	DQ6	77	(DQS8)	78	(DM8)	145	DQ41	146	DQ45
15	V _{SS}	16	V _{SS}	79	(CB2)	80	(CB6)	147	DQS5	148	DM5
17	DQ3	18	DQ7	81	V _{DD}	82	V _{DD}	149	V _{SS}	150	V _{SS}
19	DQ8	20	DQ12	83	(CB3)	84	(CB7)	151	DQ42	152	DQ46
21	V _{DD}	22	V _{DD}	85	DU	86	DU	153	DQ43	154	DQ47
23	DQ9	24	DQ13	87	V _{SS}	88	V _{SS}	155	V _{DD}	156	V _{DD}
25	DQS1	26	DM1	89	(CK2)	90	V _{SS}	157	V _{DD}	158	$\overline{\text{CK1}}$
27	V _{SS}	28	V _{SS}	91	$\overline{\text{(CK2)}}$	92	V _{DD}	159	V _{SS}	160	CK1
29	DQ10	30	DQ14	93	V _{DD}	94	V _{DD}	161	V _{SS}	162	V _{SS}
31	DQ11	32	DQ15	95	CKE1	96	CKE0	163	DQ48	164	DQ52
33	V _{DD}	34	V _{DD}	97	DU	98	DU	165	DQ49	166	DQ53
35	CK0	36	V _{DD}	99	A12	100	A11	167	V _{DD}	168	V _{DD}
37	$\overline{\text{CK0}}$	38	V _{SS}	101	A9	102	A8	169	DQS6	170	DM6
39	V _{SS}	40	V _{SS}	103	V _{SS}	104	V _{SS}	171	DQ50	172	DQ54
Key				105	A7	106	A6	173	V _{SS}	174	V _{SS}
				107	A5	108	A4	175	DQ51	176	DQ55
41	DQ16	42	DQ20	109	A3	110	A2	177	DQ56	178	DQ60
43	DQ17	44	DQ21	111	A1	112	A0	179	V _{DD}	180	V _{DD}
45	V _{DD}	46	V _{DD}	113	V _{DD}	114	V _{DD}	181	DQ57	182	DQ61
47	DQS2	48	DM2	115	A10/AP	116	BA1	183	DQS7	184	DM7
49	DQ18	50	DQ22	117	BA0	118	$\overline{\text{RAS}}$	185	V _{SS}	186	V _{SS}
51	V _{SS}	52	V _{SS}	119	$\overline{\text{WE}}$	120	$\overline{\text{CAS}}$	187	DQ58	188	DQ62
53	DQ19	54	DQ23	121	$\overline{\text{S0}}$	122	$\overline{\text{S1}}$	189	DQ59	190	DQ63
55	DQ24	56	DQ28	123	DU	124	DU	191	V _{DD}	192	V _{DD}
57	V _{DD}	58	V _{DD}	125	V _{SS}	126	V _{SS}	193	SDA	194	SA0
59	DQ25	60	DQ29	127	DQ32	128	DQ36	195	SCL	196	SA1
61	DQS3	62	DM3	129	DQ33	130	DQ37	197	V _{DDSPD}	198	SA2
63	V _{SS}	64	V _{SS}	131	V _{DD}	132	V _{DD}	199	V _{DDID}	200	DU

Table 4

Density	Organization	Memory Ranks	SDRAMs	# of SDRAMs	# of row/bank/columns bits	Refresh	Period	Interval
128MB	16M × 64	1	16M × 16	4	13/2/9	8K	64 ms	7.8 μs
256MB	32M × 64	2	16M × 16	8	13/2/9	8K	64 ms	7.8 μs

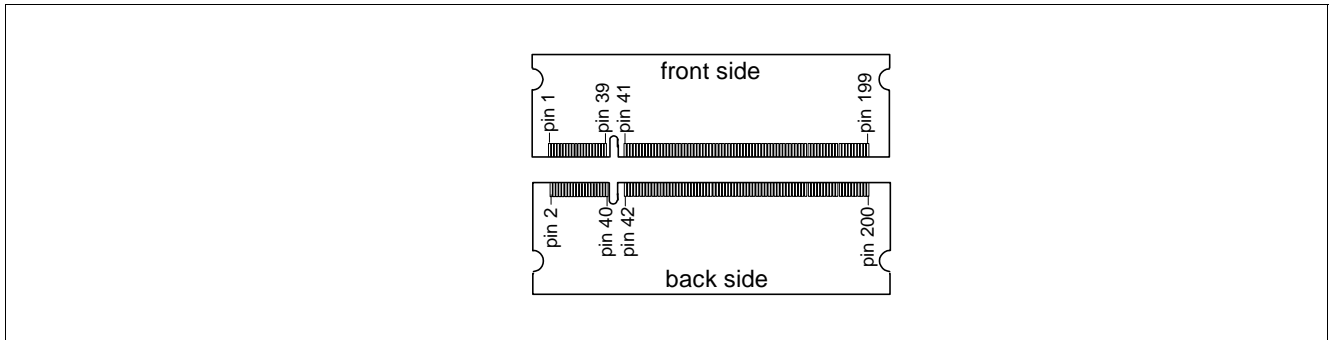


Figure 1 Pin Configuration

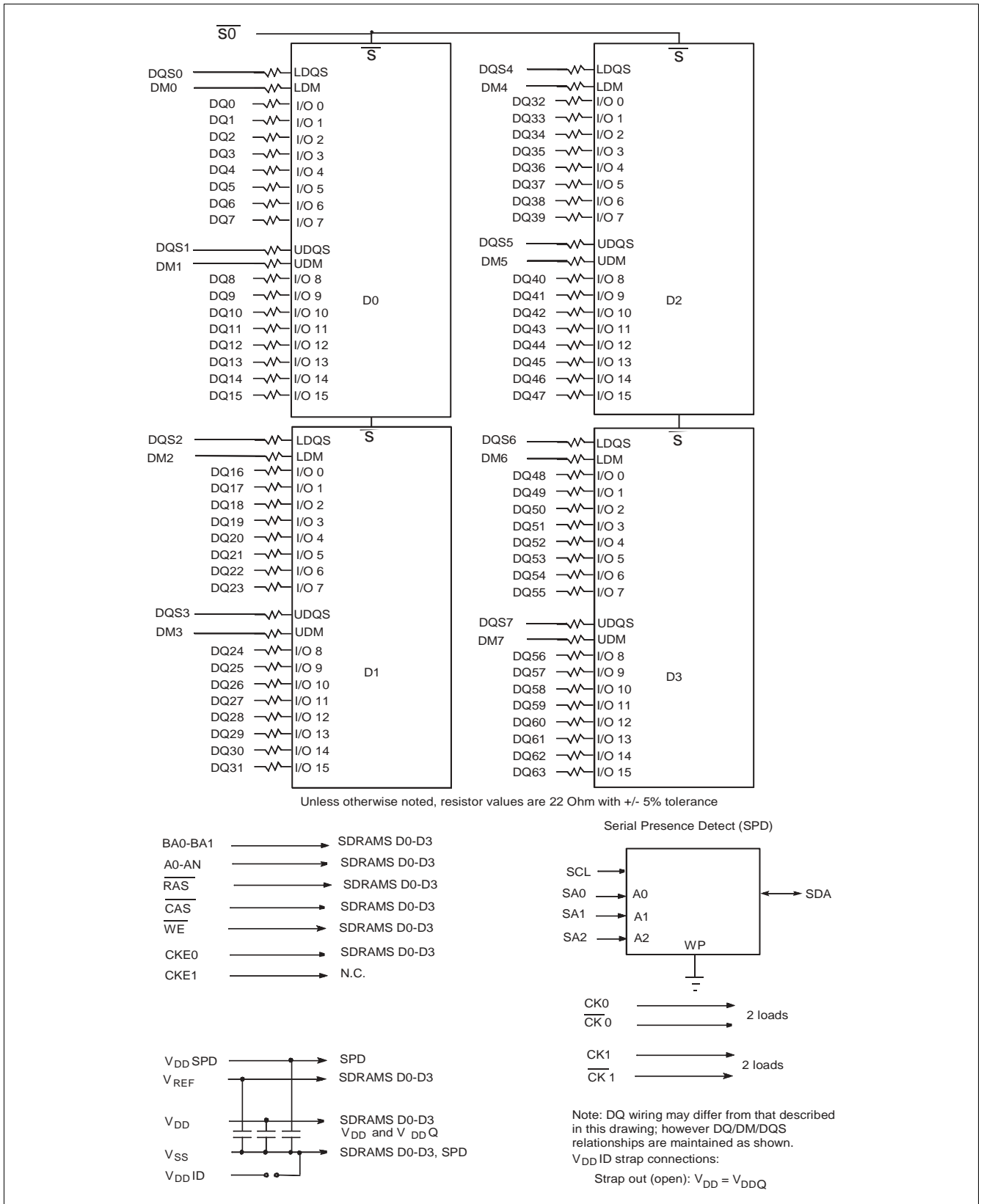


Figure 2 Block Diagram - One Rank 16M x 64 DDR SDRAM SO-DIMM HYS64D16000HDL-6-C

Pin Configuration

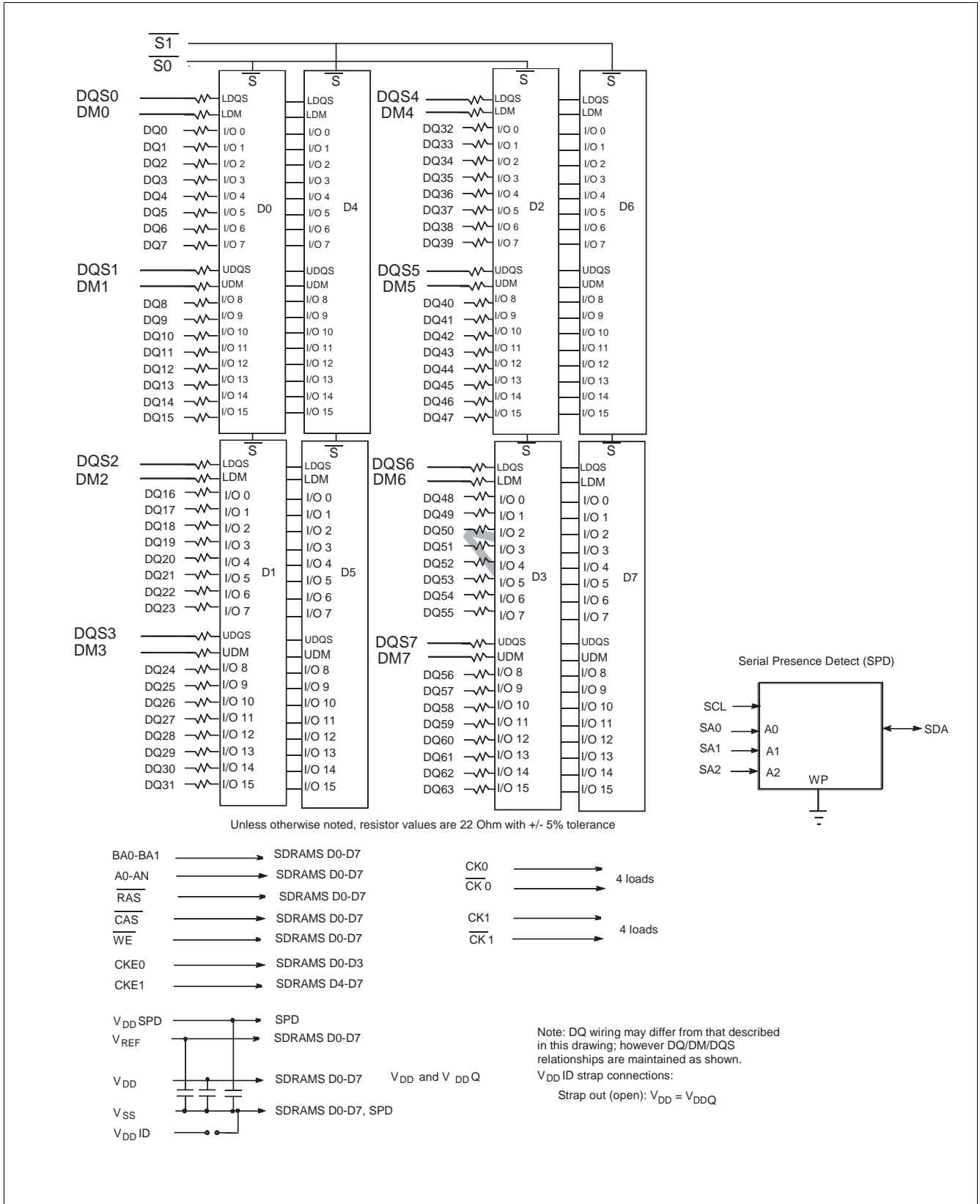


Figure 3 Block Diagram - Two Ranks 32M x 64 DDR SDRAM SO-DIMM HYS64D32020HDL-6-C

3 Electrical Characteristics

3.1 Operating Conditions

Table 5 Absolute Maximum Ratings

Parameter	Symbol	Values			Unit	Note/ Test Condition
		min.	typ.	max.		
Voltage on I/O pins relative to V_{SS}	V_{IN}, V_{OUT}	-0.5	-	$V_{DDQ} + 0.5$	V	-
Voltage on inputs relative to V_{SS}	V_{IN}	-1	-	+3.6	V	-
Voltage on V_{DD} supply relative to V_{SS}	V_{DD}	-1	-	+3.6	V	-
Voltage on V_{DDQ} supply relative to V_{SS}	V_{DDQ}	-1	-	+3.6	V	-
Operating temperature (ambient)	T_A	0	-	+70	°C	-
Storage temperature (plastic)	T_{STG}	-55	-	+150	°C	-
Power dissipation (per SDRAM component)	P_D	-	1	-	W	-
Short circuit output current	I_{OUT}	-	50	-	mA	-

Attention: Permanent damage to the device may occur if “Absolute Maximum Ratings” are exceeded. This is a stress rating only, and functional operation should be restricted to recommended operation conditions. Exposure to absolute maximum rating conditions for extended periods of time may affect device reliability and exceeding only one of the values may cause irreversible damage to the integrated circuit.

Table 6 Electrical Characteristics and DC Operating Conditions

Parameter	Symbol	Values			Unit	Note/Test Condition ¹⁾
		Min.	Typ.	Max.		
Device Supply Voltage	V_{DD}	2.3	2.5	2.7	V	
Output Supply Voltage	V_{DDQ}	2.3	2.5	2.7	V	
EEPROM supply voltage	V_{DDSPD}	2.3	2.5	3.6	V	—
Supply Voltage, I/O Supply Voltage	V_{SS}, V_{SSQ}	0		0	V	—
Input Reference Voltage	V_{REF}	$0.49 \times V_{DDQ}$	$0.5 \times V_{DDQ}$	$0.51 \times V_{DDQ}$	V	²⁾
I/O Termination Voltage (System)	V_{TT}	$V_{REF} - 0.04$		$V_{REF} + 0.04$	V	³⁾
Input High (Logic1) Voltage	$V_{IH(DC)}$	$V_{REF} + 0.15$		$V_{DDQ} + 0.3$	V	⁶⁾
Input Low (Logic0) Voltage	$V_{IL(DC)}$	-0.3		$V_{REF} - 0.15$	V	⁶⁾
Input Voltage Level, CK and \overline{CK} Inputs	$V_{IN(DC)}$	-0.3		$V_{DDQ} + 0.3$	V	⁶⁾
Input Differential Voltage, CK and \overline{CK} Inputs	$V_{ID(DC)}$	0.36		$V_{DDQ} + 0.6$	V	⁶⁾⁴⁾
VI-Matching Pull-up Current to Pull-down Current	V_{Ratio}	0.71		1.4	—	⁵⁾

Electrical Characteristics

Table 6 Electrical Characteristics and DC Operating Conditions (cont'd)

Parameter	Symbol	Values			Unit	Note/Test Condition ¹⁾
		Min.	Typ.	Max.		
Input Leakage Current	I_I	-2		2	μA	Any input $0\text{ V} \leq V_{IN} \leq V_{DD}$; All other pins not under test = 0 V ⁶⁾⁷⁾
Output Leakage Current	I_{OZ}	-5		5	μA	DQs are disabled; $0\text{ V} \leq V_{OUT} \leq V_{DDQ}$ ⁶⁾
Output High Current, Normal Strength Driver	I_{OH}	—		-16.2	mA	$V_{OUT} = 1.95\text{ V}$ ⁶⁾
Output Low Current, Normal Strength Driver	I_{OL}	16.2		—	mA	$V_{OUT} = 0.35\text{ V}$ ⁶⁾

1) $0\text{ }^\circ\text{C} \leq T_A \leq 70\text{ }^\circ\text{C}$

2) Peak to peak AC noise on V_{REF} may not exceed $\pm 2\%$ $V_{REF(DC)}$. V_{REF} is also expected to track noise variations in V_{DDQ} .

3) V_{TT} is not applied directly to the device. V_{TT} is a system supply for signal termination resistors, is expected to be set equal to V_{REF} , and must track variations in the DC level of V_{REF} .

4) V_{ID} is the magnitude of the difference between the input level on CK and the input level on \overline{CK} .

5) The ratio of the pull-up current to the pull-down current is specified for the same temperature and voltage, over the entire temperature and voltage range, for device drain to source voltage from 0.25 to 1.0 V. For a given output, it represents the maximum difference between pull-up and pull-down drivers due to process variation.

6) Inputs are not recognized as valid until V_{REF} stabilizes.

7) Values are shown per DDR SDRAM component

3.2 Current Specification and Conditions

Table 7 I_{DD} Conditions

Parameter	Symbol
Operating Current 0 one bank; active/ precharge; DQ, DM, and DQS inputs changing once per clock cycle; address and control inputs changing once every two clock cycles.	I_{DD0}
Operating Current 1 one bank; active/read/precharge; Burst Length = 4; see component data sheet.	I_{DD1}
Precharge Power-Down Standby Current all banks idle; power-down mode; $CKE \leq V_{IL,MAX}$	I_{DD2P}
Precharge Floating Standby Current $\overline{CS} \geq V_{IH,MIN}$, all banks idle; $CKE \geq V_{IH,MIN}$; address and other control inputs changing once per clock cycle; $V_{IN} = V_{REF}$ for DQ, DQS and DM.	I_{DD2F}
Precharge Quiet Standby Current $\overline{CS} \geq V_{IH,MIN}$, all banks idle; $CKE \geq V_{IH,MIN}$; $V_{IN} = V_{REF}$ for DQ, DQS and DM; address and other control inputs stable at $\geq V_{IH,MIN}$ or $\leq V_{IL,MAX}$.	I_{DD2Q}
Active Power-Down Standby Current one bank active; power-down mode; $CKE \leq V_{IL,MAX}$; $V_{IN} = V_{REF}$ for DQ, DQS and DM.	I_{DD3P}
Active Standby Current one bank active; $\overline{CS} \geq V_{IH,MIN}$; $CKE \geq V_{IH,MIN}$; $t_{RC} = t_{RAS,MAX}$; DQ, DM and DQS inputs changing twice per clock cycle; address and control inputs changing once per clock cycle.	I_{DD3N}
Operating Current Read one bank active; Burst Length = 2; reads; continuous burst; address and control inputs changing once per clock cycle; 50% of data outputs changing on every clock edge; CL = 2 for DDR266(A), CL = 3 for DDR333 and DDR400B; $I_{OUT} = 0$ mA	I_{DD4R}
Operating Current Write one bank active; Burst Length = 2; writes; continuous burst; address and control inputs changing once per clock cycle; 50% of data outputs changing on every clock edge; CL = 2 for DDR266(A), CL = 3 for DDR333 and DDR400B	I_{DD4W}
Auto-Refresh Current $t_{RC} = t_{RFC,MIN}$, burst refresh	I_{DD5}
Self-Refresh Current $CKE \leq 0.2$ V; external clock on	I_{DD6}
Operating Current 7 four bank interleaving with Burst Length = 4; see component data sheet.	I_{DD7}

Table 8 I_{DD} Specification

Part Number & Organization	HYS64D16000HDL-6-C		HYS64D32020HDL-6-C		Unit	Note ¹⁾²⁾
	128MB		256MB			
Symbol	×64		×64		mA	
	1 Rank		2 Ranks			
	-6		-6			
	typ.	max.	typ.	max.		
I_{DD0}	260	300	396	460		³⁾
I_{DD1}	320	380	456	540		³⁾⁴⁾
I_{DD2P}	14	18	28	36		⁵⁾
I_{DD2F}	100	120	200	240		⁵⁾
I_{DD2Q}	320	96	640	192		⁵⁾
I_{DD3P}	44	60	88	120		⁵⁾
I_{DD3N}	136	160	272	320		⁵⁾
I_{DD4R}	340	400	476	560		³⁾⁴⁾
I_{DD4W}	360	440	496	600		³⁾
I_{DD5}	540	640	676	800		³⁾
I_{DD6}	6	6	11	11		⁵⁾
I_{DD7}	820	960	956	1120		³⁾⁴⁾

- 1) Module I_{DD} values are calculated on the basis of component I_{DD} and can be measured differently according to DQ loading capacity.
- 2) Test condition for maximum values: $V_{DD} = 2.7 \text{ V}$, $T_A = 10 \text{ °C}$
- 3) The module I_{DDx} values are calculated from the I_{DDx} values of the component data sheet as follows:
 $m \times I_{DDx}[\text{component}] + n \times I_{DD3N}[\text{component}]$ with m and n number of components of rank 1 and 2; $n=0$ for 1 rank modules
- 4) DQ I/O (I_{DDQ}) currents are not included in the calculations (see note 1)
- 5) The module I_{DDx} values are calculated from the component I_{DDx} data sheet values as: $(m + n) \times I_{DDx}[\text{component}]$

3.3 AC Characteristics

Table 9 AC Timing - Absolute Specifications -6

Parameter	Symbol	-6		Unit	Note/ Test Condition ¹⁾
		DDR333			
		Min.	Max.		
DQ output access time from $\overline{CK}/\overline{CK}$	t_{AC}	-0.7	+0.7	ns	2)3)4)5)
DQS output access time from $\overline{CK}/\overline{CK}$	t_{DQSCK}	-0.6	+0.6	ns	2)3)4)5)
CK high-level width	t_{CH}	0.45	0.55	t_{CK}	2)3)4)5)
CK low-level width	t_{CL}	0.45	0.55	t_{CK}	2)3)4)5)
Clock Half Period	t_{HP}	min. (t_{CL} , t_{CH})		ns	2)3)4)5)
Clock cycle time	t_{CK}	6	12	ns	CL = 3.0 2)3)4)5)
		6	12	ns	CL = 2.5 2)3)4)5)
		7.5	12	ns	CL = 2.0 2)3)4)5)
DQ and DM input hold time	t_{DH}	0.45	—	ns	2)3)4)5)
DQ and DM input setup time	t_{DS}	0.45	—	ns	2)3)4)5)
Control and Addr. input pulse width (each input)	t_{IPW}	2.2	—	ns	2)3)4)5)6)
DQ and DM input pulse width (each input)	t_{DIPW}	1.75	—	ns	2)3)4)5)6)
Data-out high-impedance time from $\overline{CK}/\overline{CK}$	t_{HZ}	-0.7	+0.7	ns	2)3)4)5)7)
Data-out low-impedance time from $\overline{CK}/\overline{CK}$	t_{LZ}	-0.7	+0.7	ns	2)3)4)5)7)
Write command to 1 st DQS latching transition	t_{DQSS}	0.75	1.25	t_{CK}	2)3)4)5)
DQS-DQ skew (DQS and associated DQ signals)	t_{DQSQ}	—	+0.45	ns	TSOPII 2)3)4)5)
Data hold skew factor	t_{QHS}	—	+0.55	ns	TSOPII 2)3)4)5)
DQ/DQS output hold time	t_{QH}	$t_{HP} - t_{QHS}$	—	ns	2)3)4)5)
DQS input low (high) pulse width (write cycle)	$t_{DQSL,H}$	0.35	—	t_{CK}	2)3)4)5)
DQS falling edge to CK setup time (write cycle)	t_{DSS}	0.2	—	t_{CK}	2)3)4)5)
DQS falling edge hold time from CK (write cycle)	t_{DSH}	0.2	—	t_{CK}	2)3)4)5)
Mode register set command cycle time	t_{MRD}	2	—	t_{CK}	2)3)4)5)
Write preamble setup time	t_{WPRES}	0	—	ns	2)3)4)5)8)
Write postamble	t_{WPST}	0.40	0.60	t_{CK}	2)3)4)5)9)
Write preamble	t_{WPRE}	0.25	—	t_{CK}	2)3)4)5)
Address and control input setup time	t_{IS}	0.75	—	ns	fast slew rate 3)4)5)6)10)
		0.8	—	ns	slow slew rate 3)4)5)6)10)
Address and control input hold time	t_{IH}	0.75	—	ns	fast slew rate 3)4)5)6)10)
		0.8	—	ns	slow slew rate 3)4)5)6)10)
Read preamble	t_{RPRE}	0.9	1.1	t_{CK}	2)3)4)5)
Read postamble	t_{RPST}	0.40	0.60	t_{CK}	2)3)4)5)
Active to Precharge command	t_{RAS}	42	70E+3	ns	2)3)4)5)
Active to Active/Auto-refresh command period	t_{RC}	60	—	ns	2)3)4)5)

Table 9 AC Timing - Absolute Specifications -6

Parameter	Symbol	-6		Unit	Note/ Test Condition ¹⁾
		DDR333			
		Min.	Max.		
Auto-refresh to Active/Auto-refresh command period	t_{RFC}	72	—	ns	2)3)4)5)
Active to Read or Write delay	t_{RCD}	18	—	ns	2)3)4)5)
Precharge command period	t_{RP}	18	—	ns	2)3)4)5)
Active to Autoprecharge delay	t_{RAP}	18	—	ns	2)3)4)5)
Active bank A to Active bank B command	t_{RRD}	12	—	ns	2)3)4)5)
Write recovery time	t_{WR}	15	—	ns	2)3)4)5)
Auto precharge write recovery + precharge time	t_{DAL}			t_{CK}	2)3)4)5)11)
Internal write to read command delay	t_{WTR}	1	—	t_{CK}	2)3)4)5)
Exit self-refresh to non-read command	t_{XSNR}	75	—	ns	2)3)4)5)
Exit self-refresh to read command	t_{XSRD}	200	—	t_{CK}	2)3)4)5)
Average Periodic Refresh Interval	t_{REFI}	—	7.8	μ s	2)3)4)5)12)

- 1) $0\text{ }^{\circ}\text{C} \leq T_A \leq 70\text{ }^{\circ}\text{C}$; $V_{DDQ} = 2.5\text{ V} \pm 0.2\text{ V}$, $V_{DD} = +2.5\text{ V} \pm 0.2\text{ V}$
- 2) Input slew rate $\geq 1\text{ V/ns}$
- 3) The CK/ $\overline{\text{CK}}$ input reference level (for timing reference to CK/ $\overline{\text{CK}}$) is the point at which CK and $\overline{\text{CK}}$ cross: the input reference level for signals other than CK/ $\overline{\text{CK}}$, is V_{REF} . CK/ $\overline{\text{CK}}$ slew rate are $\geq 1.0\text{ V/ns}$.
- 4) Inputs are not recognized as valid until V_{REF} stabilizes.
- 5) The Output timing reference level, as measured at the timing reference point indicated in AC Characteristics (note 3) is V_{TT} .
- 6) These parameters guarantee device timing, but they are not necessarily tested on each device.
- 7) t_{HZ} and t_{LZ} transitions occur in the same access time windows as valid data transitions. These parameters are not referred to a specific voltage level, but specify when the device is no longer driving (HZ), or begins driving (LZ).
- 8) The specific requirement is that DQS be valid (HIGH, LOW, or some point on a valid transition) on or before this CK edge. A valid transition is defined as monotonic and meeting the input slew rate specifications of the device. When no writes were previously in progress on the bus, DQS will be transitioning from Hi-Z to logic LOW. If a previous write was in progress, DQS could be HIGH, LOW, or transitioning from HIGH to LOW at this time, depending on t_{DQSS} .
- 9) The maximum limit for this parameter is not a device limit. The device operates with a greater value for this parameter, but system performance (bus turnaround) degrades accordingly.
- 10) Fast slew rate $\geq 1.0\text{ V/ns}$, slow slew rate $\geq 0.5\text{ V/ns}$ and $< 1\text{ V/ns}$ for command/address and CK & $\overline{\text{CK}}$ slew rate $> 1.0\text{ V/ns}$, measured between $V_{OH(ac)}$ and $V_{OL(ac)}$.
- 11) For each of the terms, if not already an integer, round to the next highest integer. t_{CK} is equal to the actual system clock cycle time.
- 12) A maximum of eight Autorefresh commands can be posted to any given DDR SDRAM device.

4 SPD Contents

Table 10 SPD Codes for HYS64D[32020/16000]HDL-6-C

	Part Number & Organization	HYS64D16000HDL-6-C	HYS64D32020HDL-6-C
		128MB	256MB
		×64	×64
		1 Rank	2 Ranks
		-6	-6
Byte#	Description	HEX	HEX
0	Programmed SPD Bytes in E2PROM	80	80
1	Total number of Bytes in E2PROM	08	08
2	Memory Type DDR = 07h	07	07
3	# of Row Addresses	0D	0D
4	# Number of Column Addresses	09	09
5	# of DIMM Ranks	01	02
6	Data Width (LSB)	40	40
7	Data Width (MSB)	00	00
8	Interface Voltage Levels	04	04
9	tCK @ CLmax (Byte 18) [ns]	60	60
10	tAC SDRAM @ CLmax (Byte 18) [ns]	70	70
11	DIMM Configuration Type (non- / ECC)	00	00
12	Refresh Rate	82	82
13	Primary SDRAM width	10	10
14	Error Checking SDRAM width	00	00
15	tCCD [cycles]	01	01
16	Burst Length Supported	0E	0E
17	Number of Banks on SDRAM	04	04
18	CAS Latency	0C	0C
19	CS Latency	01	01
20	WE (Write) Latency	02	02
21	DIMM Attributes	20	20
22	Component Attributes	C1	C1
23	tCK @ CLmax -0.5 (Byte 18) [ns]	75	75
24	tAC SDRAM @ CLmax -0.5 [ns]	70	70
25	tCK @ CLmax -1 (Byte 18) [ns]	00	00
26	tAC SDRAM @ CLmax -1 [ns]	00	00
27	tRPmin (ns)	48	48
28	tRRDmin [ns]	30	30
29	tRCDmin [ns]	48	48
30	tRASmin [ns]	2A	2A
31	Module Density per Rank	20	20
32	tAS, tCS [ns]	75	75
33	tAH, TCH [ns]	75	75
34	tDS [ns]	45	45

Table 10 SPD Codes for HYS64D[32020/16000]HDL-6-C

	Part Number & Organization	HYS64D16000HDL-6-C	HYS64D32020HDL-6-C
		128MB	256MB
		×64	×64
		1 Rank	2 Ranks
		-6	-6
Byte#	Description	HEX	HEX
35	tDH [ns]	45	45
36 - 40	not used	00	00
41	tRCmin [ns]	3C	3C
42	tRFCmin [ns]	48	48
43	tCKmax [ns]	30	30
44	tDQSQmax [ns]	2D	2D
45	tQHSmax [ns]	55	55
46 - 61	not used	00	00
62	SPD Revision	00	00
63	Checksum of Byte 0-62 (LSB only)	E8	E9
64	JEDEC ID Code for Infineon	C1	C1
65	JEDEC ID Code for Infineon	00	00
66	JEDEC ID Code for Infineon	00	00
67	JEDEC ID Code for Infineon	00	00
68	JEDEC ID Code for Infineon	00	00
69	JEDEC ID Code for Infineon	00	00
70	JEDEC ID Code for Infineon	00	00
71	JEDEC ID Code for Infineon	00	00
72	Module Manufacturer Location	xx	xx
73	Part Number, Char 1	36	36
74	Part Number, Char 2	34	34
75	Part Number, Char 3	44	44
76	Part Number, Char 4	31	33
77	Part Number, Char 5	36	32
78	Part Number, Char 6	30	30
79	Part Number, Char 7	30	32
80	Part Number, Char 8	30	30
81	Part Number, Char 9	48	48
82	Part Number, Char 10	44	44
83	Part Number, Char 11	4C	4C
84	Part Number, Char 12	36	36
85	Part Number, Char 13	43	43
86	Part Number, Char 14	20	20
87	Part Number, Char 15	20	20
88	Part Number, Char 16	20	20
89	Part Number, Char 17	20	20

Table 10 SPD Codes for HYS64D[32020/16000]HDL-6-C

	Part Number & Organization	HYS64D16000HDL-6-C	HYS64D32020HDL-6-C
		128MB	256MB
		×64	×64
		1 Rank	2 Ranks
		-6	-6
Byte#	Description	HEX	HEX
90	Part Number, Char 18	20	20
91	Module Revision Code	xx	xx
92	Test Program Revision Code	xx	xx
93	Module Manufacturing Date Year	xx	xx
94 - 98	Module Manufacturing Date Week	xx	xx
99 - 127	not used	00	00

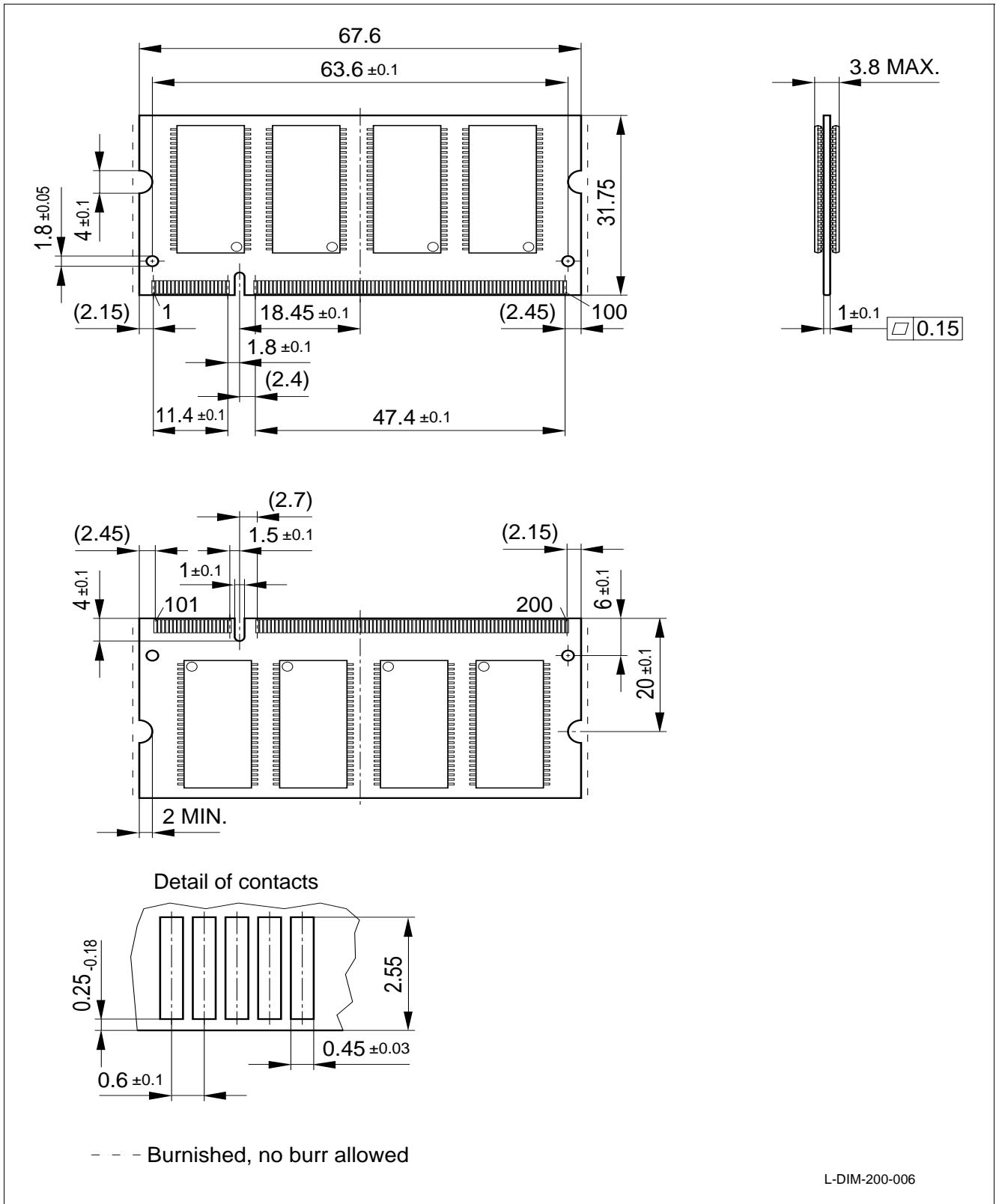


Figure 5 Package Outlines – Raw Card A DDR SDRAM SO-DIMM HYS64D32020HDL-6-C

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